

<b>Notice of References Cited</b>	Application/Control No. 10/550,202	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Sang Y. Paik	Art Unit 3742	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,593,608	01-1997	Suzuki, Fujio	219/492
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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